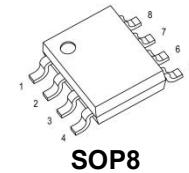


30V N-Channel MOSFET

Product Summary

V_{(BR)DSS}	R_{DS(on)TYP}	I_D
30V	8mΩ@10V	11.5A
	12mΩ@4.5V	

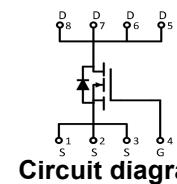
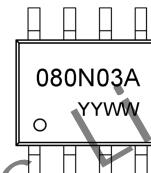


Features

- ◆ Very Low On-resistance R_{DS(ON)}
- ◆ LowCrss
- ◆ Fast switching
- ◆ 100% avalanche tested
- ◆ Improved dv/dt capability

Applications

- ◆ PWM Application
- ◆ Load Switch
- ◆ Power Management


Circuit diagram


080N03A : Device Code
YY : Year Code
WW : Week Code

Marking (Top View)

Order information

Device	Package	Shipping
AN080N03EL0	SOP8	4000/Tape&Reel

Absolute maximum ratings

Parameter		Symbol	Value	Units
Drain-Source Voltage		V _{DSS}	30	V
Drain Current	T _C = 25°C	I _D	11.5	A
	T _C = 70°C		9	A
Drain Current - Pulsed ¹		I _{DM}	45	A
Gate-Source Voltage		V _{GSS}	±20	V
Single Pulsed Avalanche Energy ²		E _{AS}	70	mJ
Power Dissipation	T _A = 25°C	P _D	2.5	W
Thermal Resistance, Junction-to-Ambient		R _{θJA}	50	°C/W
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		T _L	300	°C

Electrical characteristics ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Type	Max	Unit
Static Characteristics						
Drain - Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$			-1	μA
Gate - Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm20\text{V}, V_{\text{DS}}=0\text{V}$			±100	nA
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1	1.5	2.5	V
Drain-source On-resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=8\text{A}$		8	11	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=6\text{A}$		12	16	
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$		1060		pF
Output Capacitance	C_{oss}			122		
Reverse Transfer Capacitance	C_{rss}			102		
Switching Characteristics						
Total Gate Charge	Q_g	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=30\text{A}, V_{\text{GS}}=10\text{V}$		21		nC
Gate-source Charge	Q_{gs}			3		
Gate-drain Charge	Q_{gd}			5		
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=15\text{V}, R_L=1.6\Omega, I_{\text{D}}=30\text{A}$		4		ns
Turn-on Rise Time	t_r			2		
Turn-off Delay Time	$t_{\text{d}(\text{off})}$			13		
Turn-off Fall Time	t_f			7		
Source - Drain Diode Characteristics						
Drain to Source Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{SD}}=10\text{A}, T_J=25^\circ\text{C}$			1.2	V

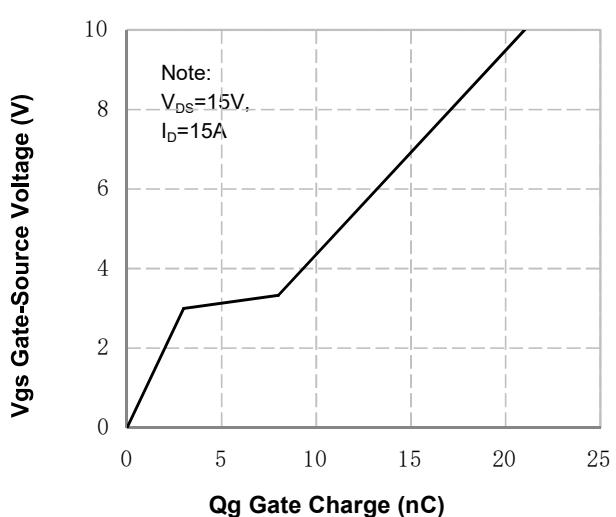
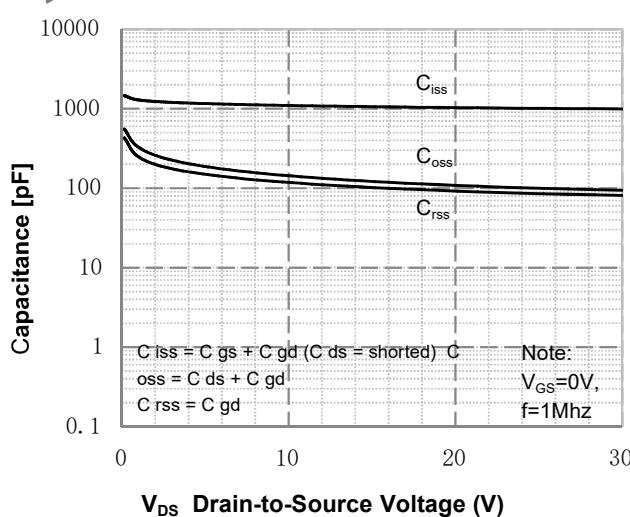
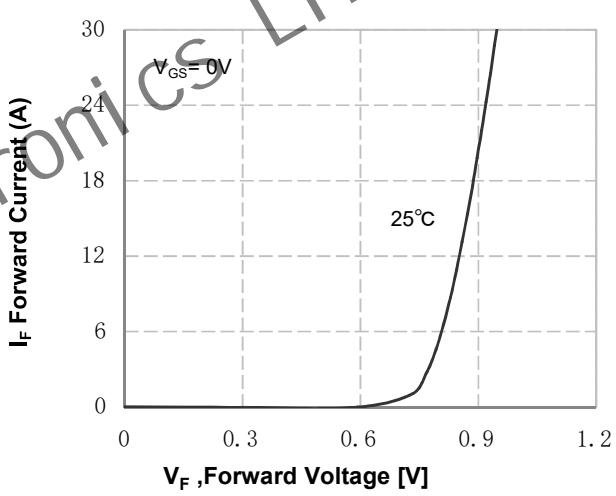
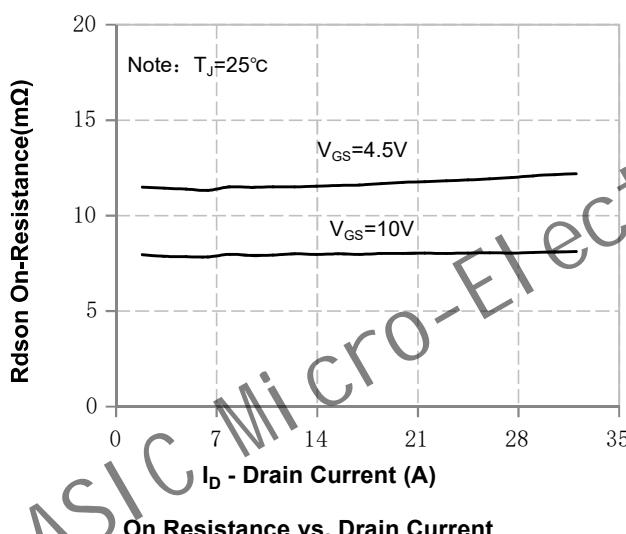
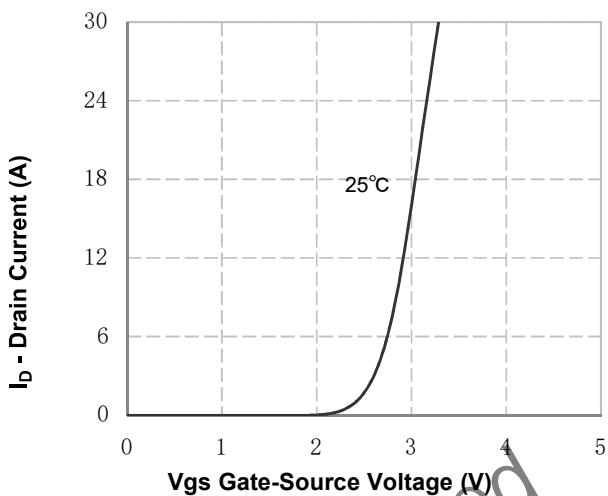
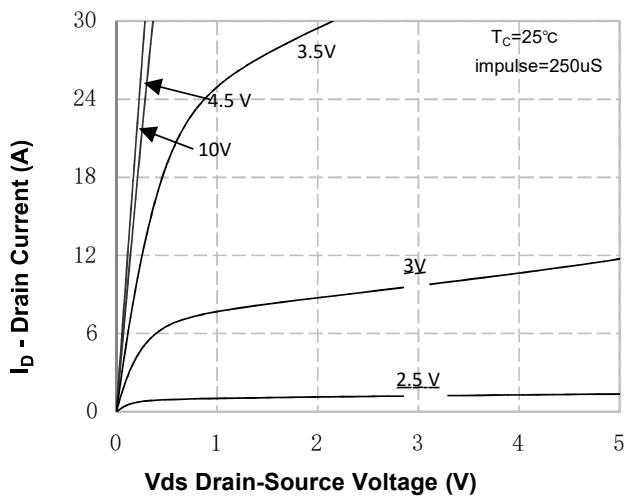
Notes:

1. Drain current limited by maximum junction temperature.
2. EAS condition: $T_J=25^\circ\text{C}$, $V_{\text{DD}}=20\text{V}$, $V_G=10\text{V}$, $L=0.5\text{mH}$.

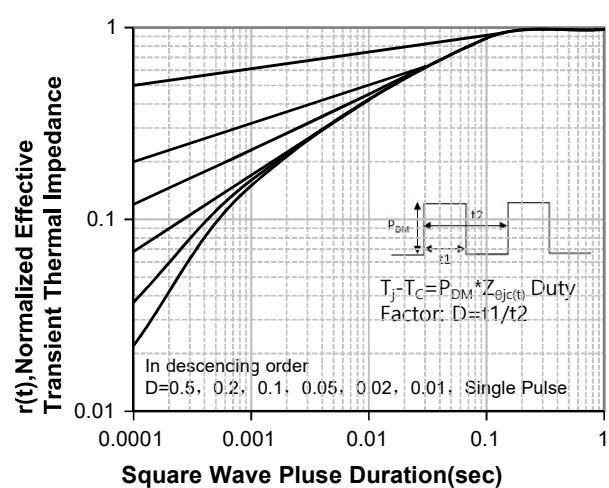
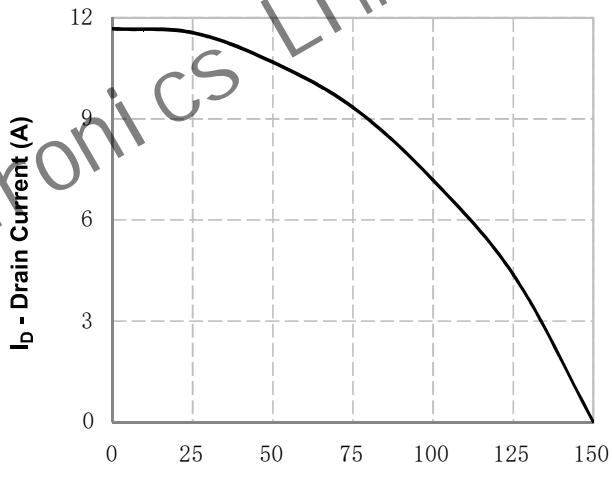
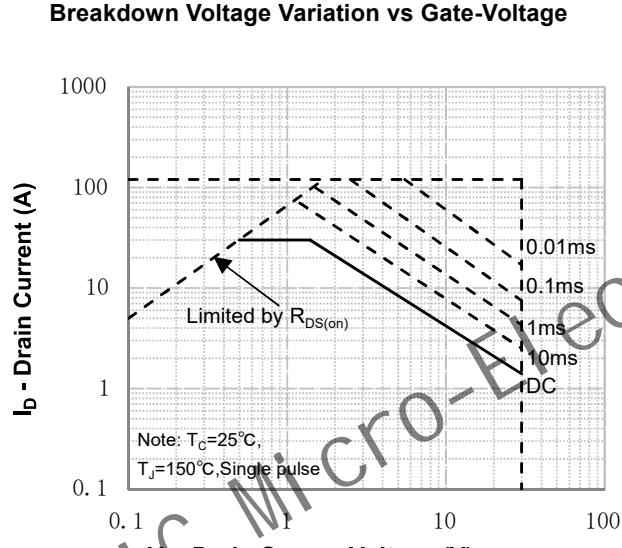
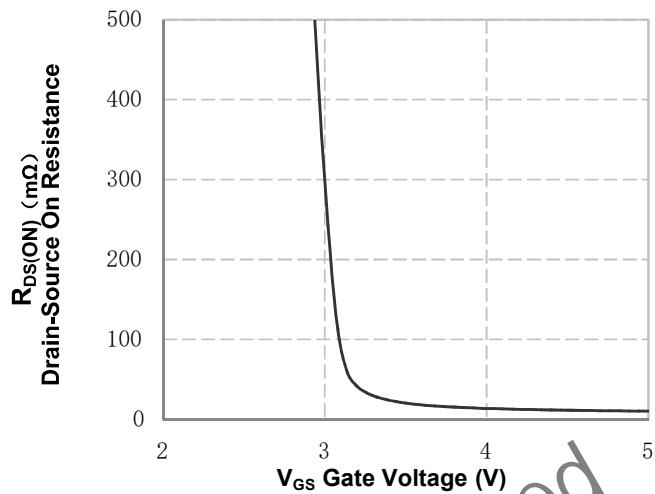
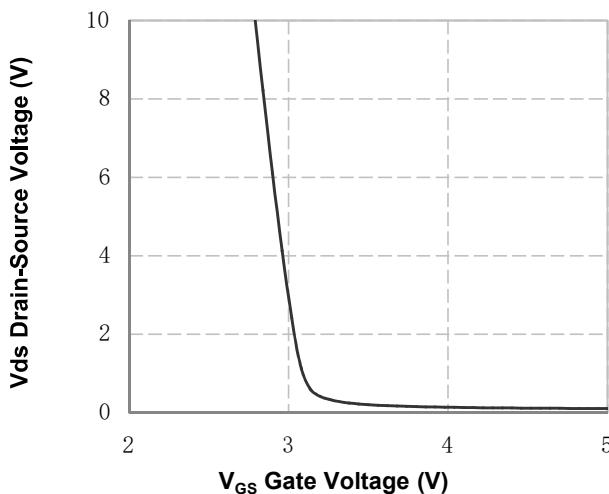
ASIC

Micro-Electronics Limited

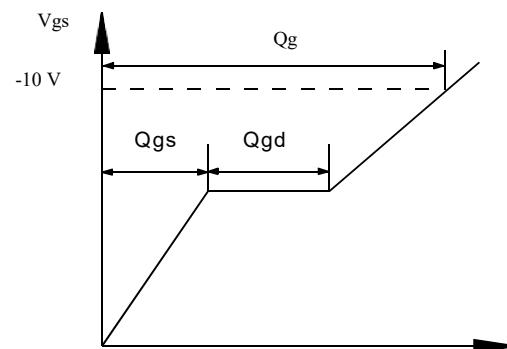
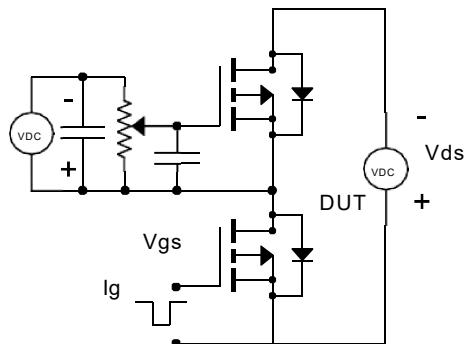
Typical characteristics



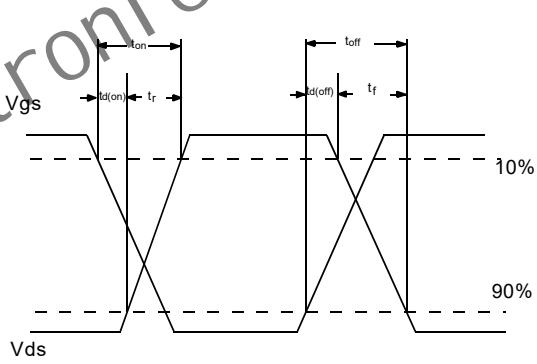
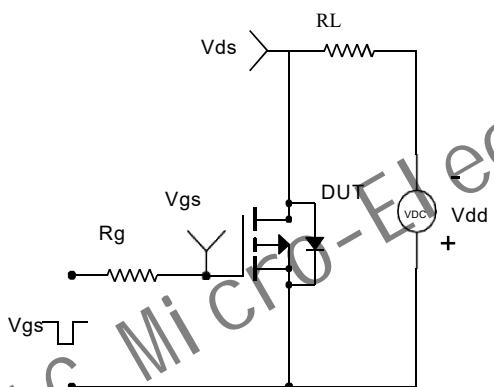
Typical characteristics



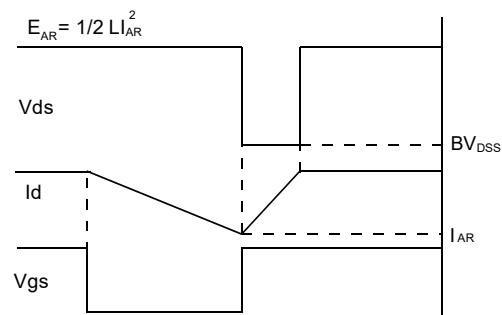
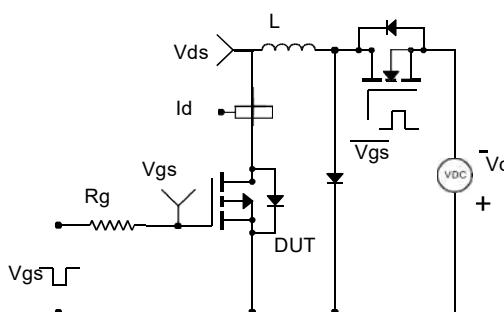
Gate Charge Test Circuit & Waveform



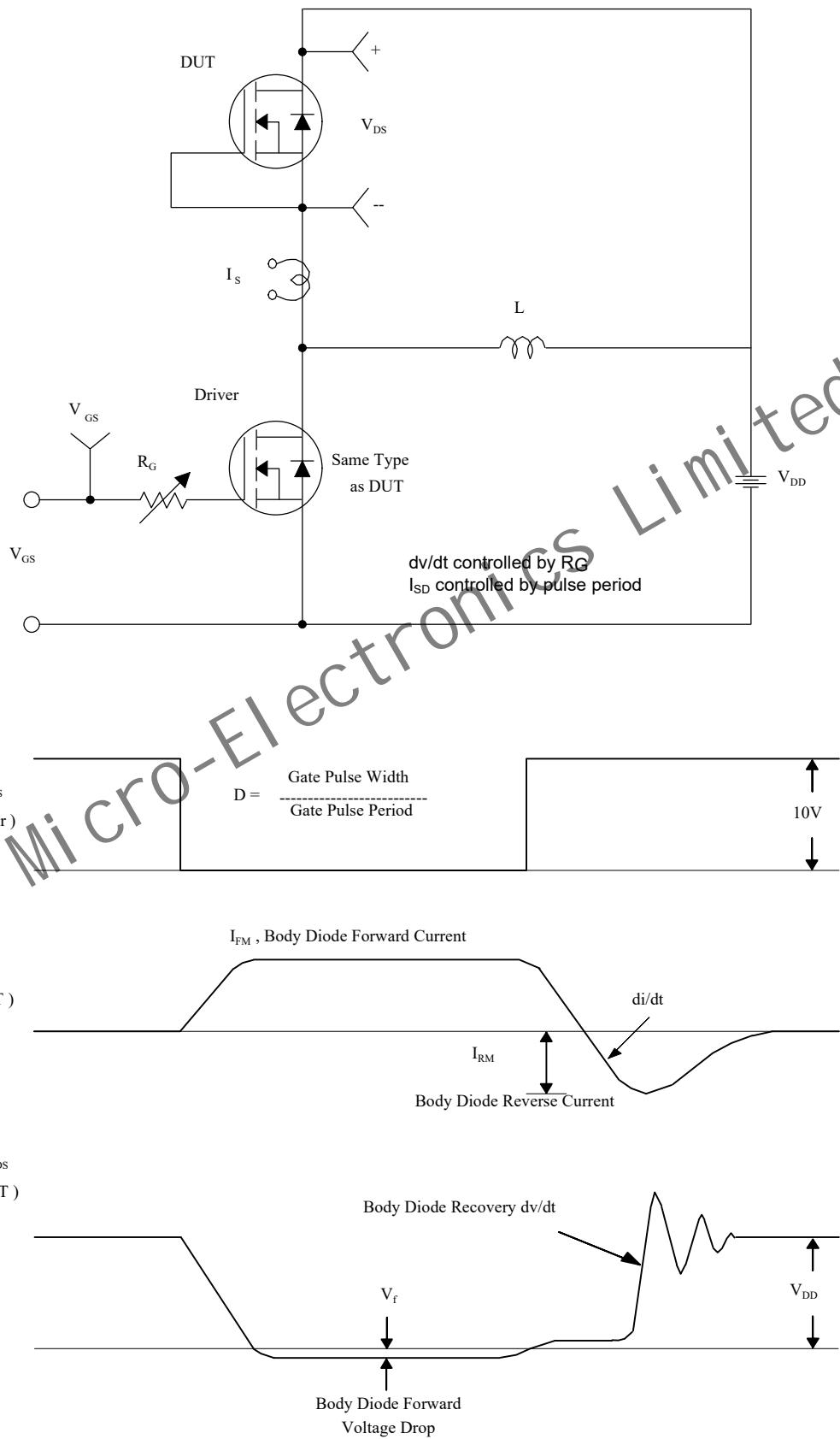
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

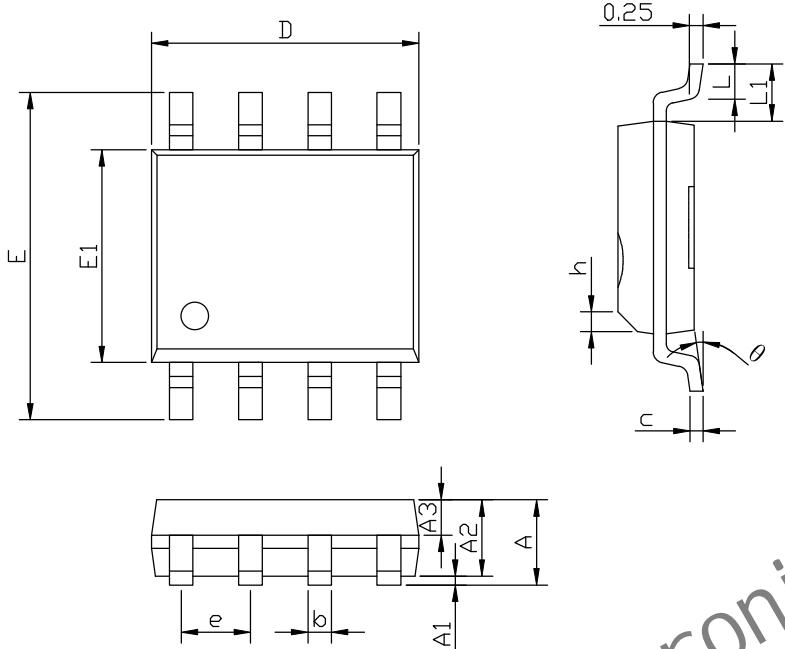


Peak Diode Recovery dv/dt Test Circuit & Waveforms



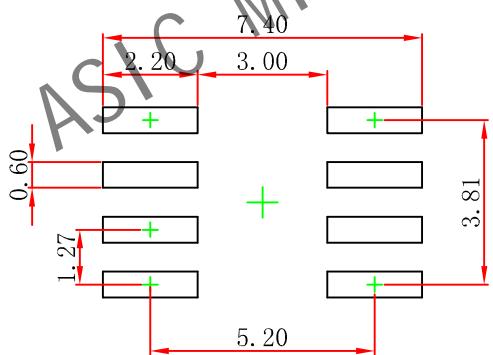
PACKAGE OUTLINE DIMENSIONS

SOP8



Symbol	Dimensions in millimeters		
	Min.	Typ.	Max.
A	-	-	1.75
A1	0.05	-	0.20
A2	1.30	1.40	1.50
A3	0.60	0.65	0.70
b	0.39	-	0.47
C	0.20	-	0.24
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.24	1.27	1.30
h	0.30	0.40	0.50
L	0.50	-	0.80
L1	1.00	1.05	1.10
θ	0°	-	8°

Recommended PCB Layout (Unit: mm)



Notes:

This recommended land pattern is for reference purposes only. Please consult your manufacturing group to ensure your PCB design guidelines are met.